# Safety and Reliability of Embedded Systems - SRES (WS 19/20) Problem Set 6

#### **Problem 1: Weibull distribution**

The so-called Weibull distribution is often used to describe the wear-out phase of components (caused by e.g. fatigue failures).

Assume that the lifetime T of a component can be described by such a Weibull distribution with parameter  $\beta = 2$ .

In order to determine the parameter  $\lambda$ , you perform the following experiment:

The experiment is commenced with a large number of components all being initially intact. After 250 hours, the number of components that survived so far is recorded. After another 50 hours, it is observed that 25% of these components now have failed.

Please calculate the parameter  $\lambda$  of the corresponding Weibull distribution.

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Failure rate of the Weibull distribution depending on the form parameter  $\beta$ 

• Life Distribution :  $F(t) = 1 - e^{-(\lambda t)^{\beta}}$ ;  $\lambda$ ,  $\beta > 0$ 

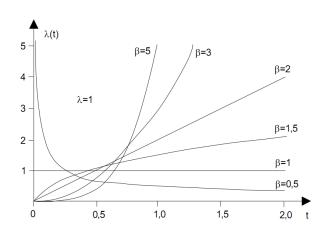
• or: 
$$F(t) = 1 - e^{\frac{1}{\alpha}t^{\beta}}; \alpha, \beta > 0, d. h. \frac{1}{\alpha} = \lambda^{\beta}$$

· Density:

$$f(t) = \frac{dF(t)}{dt} = \lambda \beta (\lambda t)^{\beta - 1} e^{-(\lambda t)^{\beta}}$$

- Reliability:  $R(t) = e^{-(\lambda t)^{\beta}}$
- · Failure rate:

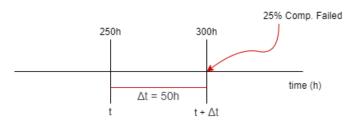
$$\lambda(t) = \frac{f(t)}{R(t)} = \lambda \beta (\lambda t)^{\beta - 1}$$



- $F(t) = P\{T \le t\}$  -> probability that lifetime T is less or equal to t, meaning that a system has already failed by t
- In our case: P ( T  $\leq 300$  ) give that P (T > 250) -> Conditional probability
- The conditional probability that a system has survived until t and fails within  $\Delta t$  is:  $1 \frac{R(t + \Delta t)}{R(t)}$

$$\frac{F(t + \Delta t) - F(t)}{1 - F(t)} = > \frac{F(250 + 50) - F(250)}{1 - F(250)} = 0.25$$

$$\frac{1 - e^{-(\lambda \cdot 300h)^2} - (1 - e^{-(\lambda \cdot 250h)^2})}{e^{-(\lambda \cdot 250h)^2}} = 0.25$$



### Because lifetime is exponentially distributed

$$\frac{e^{-(\lambda.250h)^2} - e^{-(\lambda.300h)^2}}{e^{-(\lambda.250h)^2}} = 0.25$$

$$e^{-(\lambda . 250h)^2} - e^{-(\lambda . 300h)^2} = 0.25 * e^{-(\lambda . 250h)^2}$$

$$e^{-(\lambda \, . \, \, 250h)^2} - 0.25 * \, e^{-(\lambda \, . \, \, 250h)^2} = \, e^{-(\lambda \, . \, \, 300h)^2}$$

$$(1 - 0.25) * e^{-(\lambda . 250h)^2} = e^{-(\lambda . 300h)^2}$$

$$(0.75) * e^{-(\lambda \cdot 250h)^2} = e^{-(\lambda \cdot 300h)^2}$$

$$ln(e^{-(\lambda .~250h)^2}*0.75\,) = ~ln(e^{-(\lambda .~300h)^2})$$

$$\ln(0.75) - (\lambda.250h)^2 = -(\lambda.300h)^2$$

$$(\lambda.300h)^2 - (\lambda.250h)^2 = -\ln(0.75)$$

$$27500 h^2 . \lambda^2 = -\ln(0.75)$$

$$\lambda^2 = \frac{-\ln(0.75)}{27500 \, h^2}$$

$$\lambda = \sqrt{\frac{-\ln(0.75)}{27500 \, h^2}}$$

$$\lambda = 3.234 * 10^{-3} h^{-1}$$

#### Problem 2: Musa's execution time model

Based on your experience you expect a total number of 200 failures for a software system. At present you run the system test. The initial failure rate was 0.05 / CPU-second. Your goal is to reduce the failure rate to 0.005 / CPU-second. Use Musa's execution time model to answer the following questions:

- a) How much total execution time will be necessary? How much additional execution time will be necessary to observe a failure rate of 0.005 / CPU-second after you have reached a failure rate of 0.01 / CPU-second?
  - 1. How much total execution time will be necessary?

The initial failure rate is proportional to the expected number of failure a, with the constant of proportionality b.

$$\lambda(t) = \lambda_0 \cdot e^{-\frac{\lambda_0}{a}t}$$

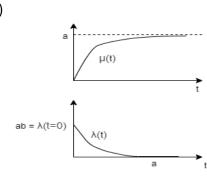
$$\mu(t) = a \cdot (1 - e^{-\frac{\lambda_0}{a}t})$$

Musa's execution model

$$\ln(\lambda(t)) = \ln(\lambda_0) - \frac{\lambda_0}{a} t$$

$$t=a\,.\frac{\ln(\lambda_0)-\ln(\lambda(t))}{\lambda_0}$$

$$t = 200 * \frac{\ln(0.05) - \ln(\lambda(0.005))}{0.05} CPU sec$$



Total execution time, t = 9210.340372 *CPU sec* 

2. How much additional execution time will be necessary to observe a failure rate of 0.005 / CPU-second after you have reached a failure rate of 0.01 / CPU-second? (see slide no 37 in Chapter 10: Reliability)

The additional time  $\Delta t$  until this target is reached,

$$\Delta t = \frac{a}{\lambda_0} \ln \frac{\lambda_{current}}{\lambda_{t \arg et}}$$

$$\Delta t = \frac{200}{0.05} \ln \frac{0.01}{0.005}$$

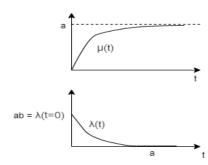
$$\Delta t = 2772.6 \ CPU \ sec$$

- b) How many failures will have occurred when you reach the failure rate of 0.005 / CPU-second? How many additional failures will occur after you have reached a failure rate of 0.01 / CPU-second until you observe a failure rate of 0.005 / CPU-second?
  - 1. How many failures will have occurred when you reach the failure rate of 0.005 / CPU-second?

$$\mu(t) = a \cdot (1 - e^{-\frac{\lambda_0}{a}t})$$

$$\mu(t) = 200 \cdot (1 - e^{-\frac{0.05}{200}9210.340372})$$

$$\mu(t) = 180 \text{ failures}$$



## 2. How many **additional failures will occur** after you have reached a failure rate of 0.01 / CPU-second until **you observe a failure rate of 0.005 / CPU-second**?

If  $\lambda$  is the present failure rate and a target  $\lambda_z$  is defined,  $\Delta \mu$  additional failures will occur until this target is reached.

$$\Delta\mu = a \cdot (\frac{\lambda - \lambda_z}{\lambda_0})$$

$$\Delta \mu = 200 \cdot (\frac{0.01 - 0.005}{0.05})$$

$$\Delta \mu = 20 \, failures$$

c) What will be the **failure rate** after you have observed 100 failures?

$$\lambda(\mu) = \lambda_0 \cdot (1 - \frac{\mu}{a})$$

$$\lambda(\mu) = 0.05 * (1 - \frac{100}{200})$$

$$\lambda(\mu) = 0.025 \; \frac{1}{\mathit{CPU sec}}$$

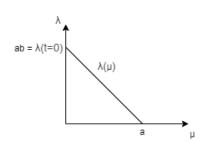
d) What will be the failure rate after 5000 CPU-seconds and how many failures have occurred until then?

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$$\lambda(t) = \lambda_0 \cdot e^{-\frac{\lambda_0}{a}t}$$

$$\lambda(t) = 0.05 * e^{-\frac{0.05}{200}5000} \frac{1}{CPU \ sec}$$

$$\lambda(t) = 0.014325 \, \frac{1}{CPU \, sec}$$



2. how many failures have occurred until then?

1. What will be the failure rate after 5000 CPU-seconds?

$$\mu(t) = a \cdot (1 - e^{-\frac{\lambda_0}{a}t})$$

$$\mu(t) = 200.(1 - e^{-\frac{0.05}{200}5000})$$

$$\mu(t) = 143 \, failures$$